



- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

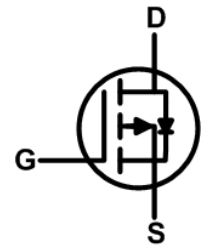
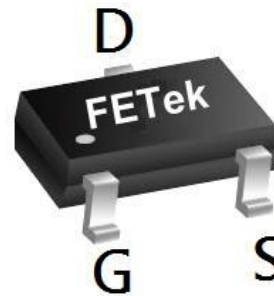
Product Summary

| BVDSS | RDSON | ID |
|-------|-------|-------|
| -60V | 180mΩ | -1.7A |

Description

The FKN6107 is the high cell density trenched P-ch MOSFETs, which provides excellent RDSON and efficiency for most of the small power switching and load switch applications.

The FKN6107 meet the RoHS and Green Product requirement with full function reliability approved.

SOT23 Pin Configuration

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|--------------------------|---------------------------------------------|------------|------------|
| V_{DS} | Drain-Source Voltage | -60 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ -10V^1$ | -1.7 | A |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ -10V^1$ | -1.4 | A |
| I_{DM} | Pulsed Drain Current ² | -7 | A |
| $P_D @ T_A = 25^\circ C$ | Total Power Dissipation ³ | 1 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|-----------------|--------------------------------------------------|------|------|--------------|
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient ¹ | --- | 125 | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case ¹ | --- | 80 | $^\circ C/W$ |

**Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)**

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------|------------------------------------------------|-----------------------------------------------------|------|--------|-----------|----------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=-250\mu A$ | -60 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | BV_{DSS} Temperature Coefficient | Reference to 25°C , $I_D=-1\text{mA}$ | --- | -0.021 | --- | $V/^\circ\text{C}$ |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance ² | $V_{GS}=-10V, I_D=-1.5A$ | --- | --- | 180 | m Ω |
| | | $V_{GS}=-4.5V, I_D=-1A$ | --- | --- | 266 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=-250\mu A$ | -1.0 | --- | -2.5 | V |
| $\Delta V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | 4.08 | --- | $\text{mV}/^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=-48V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | 1 | μA |
| | | $V_{DS}=-48V, V_{GS}=0V, T_J=55^\circ\text{C}$ | --- | --- | 5 | |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |
| gfs | Forward Transconductance | $V_{DS}=-5V, I_D=-1.5A$ | --- | 5.9 | --- | S |
| Q_g | Total Gate Charge (-4.5V) | $V_{DS}=-20V, V_{GS}=-4.5V, I_D=-1.5A$ | --- | 4.6 | --- | nC |
| Q_{gs} | Gate-Source Charge | | --- | 1.4 | --- | |
| Q_{gd} | Gate-Drain Charge | | --- | 1.62 | --- | |
| $T_{d(on)}$ | Turn-On Delay Time | $V_{DS}=-15V, V_{GS}=-10V, R_G=3.3\Omega, I_D=-1A$ | --- | 17.4 | --- | ns |
| T_r | Rise Time | | --- | 5.4 | --- | |
| $T_{d(off)}$ | Turn-Off Delay Time | | --- | 37.2 | --- | |
| T_f | Fall Time | | --- | 2.4 | --- | |
| C_{iss} | Input Capacitance | $V_{DS}=-15V, V_{GS}=0V, f=1\text{MHz}$ | --- | 531 | --- | pF |
| C_{oss} | Output Capacitance | | --- | 59 | --- | |
| C_{riss} | Reverse Transfer Capacitance | | --- | 38 | --- | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|------------------------------------------|--------------------------------------------|------|------|------|------|
| I_S | Continuous Source Current ^{1,4} | $V_G=V_D=0V$, Force Current | --- | --- | -1.7 | A |
| I_{SM} | Pulsed Source Current ^{2,4} | | --- | --- | -7 | A |
| V_{SD} | Diode Forward Voltage ² | $V_{GS}=0V, I_S=-1A, T_J=25^\circ\text{C}$ | --- | --- | -1.2 | V |

Note :

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- The power dissipation is limited by 150°C junction temperature
- The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

Typical Characteristics

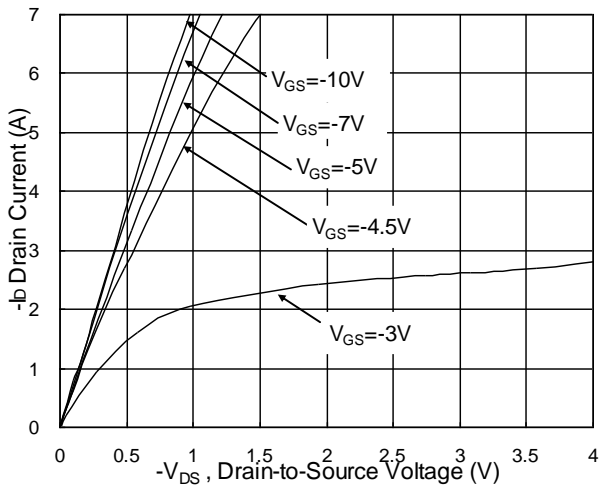


Fig.1 Typical Output Characteristics

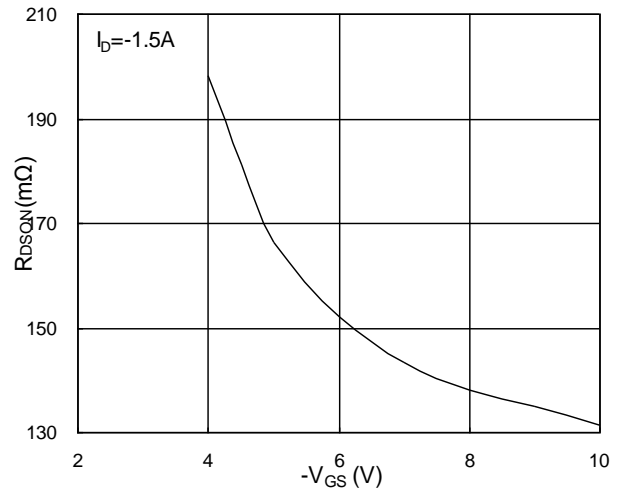


Fig.2 On-Resistance v.s Gate-Source

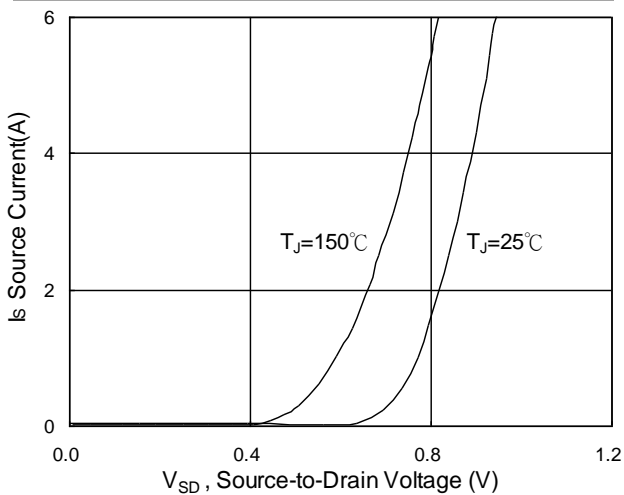


Fig.3 Forward Characteristics Of Reverse

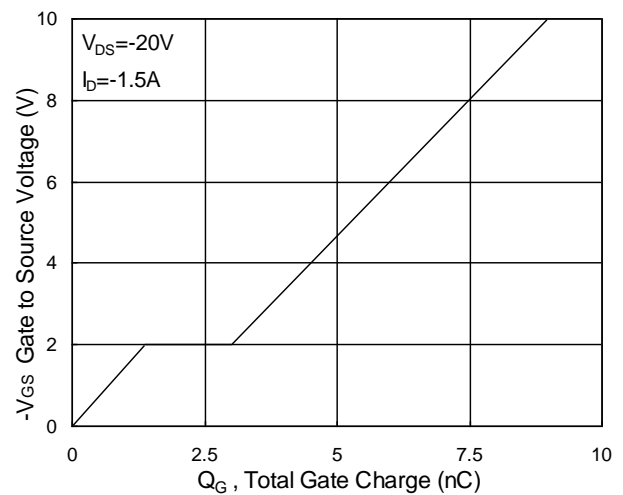


Fig.4 Gate-Charge Characteristics

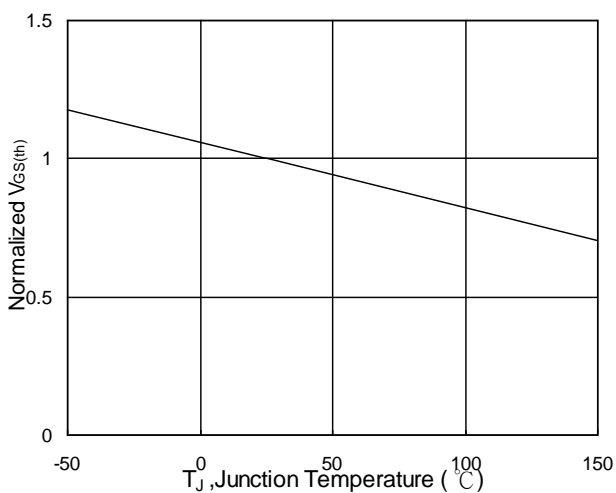


Fig.5 Normalized V_{GS(th)} v.s T_J

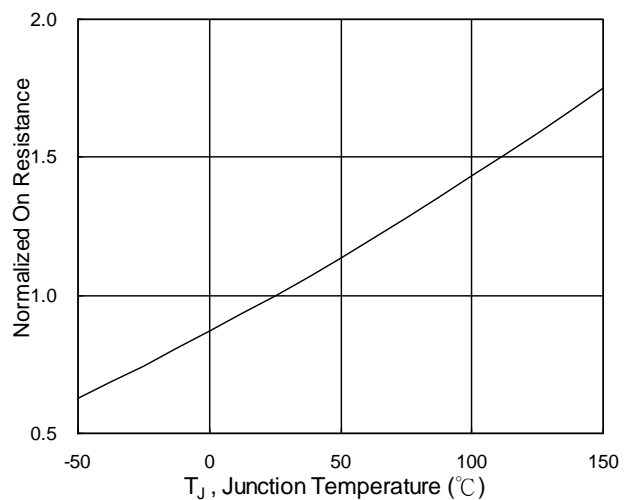


Fig.6 Normalized R_{DS(on)} v.s T_J

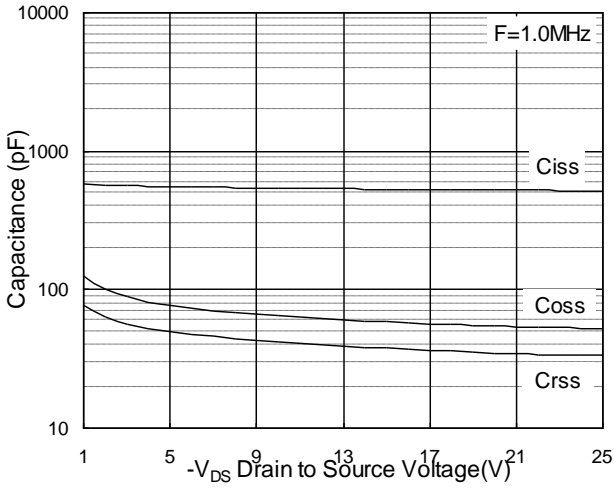


Fig.7 Capacitance

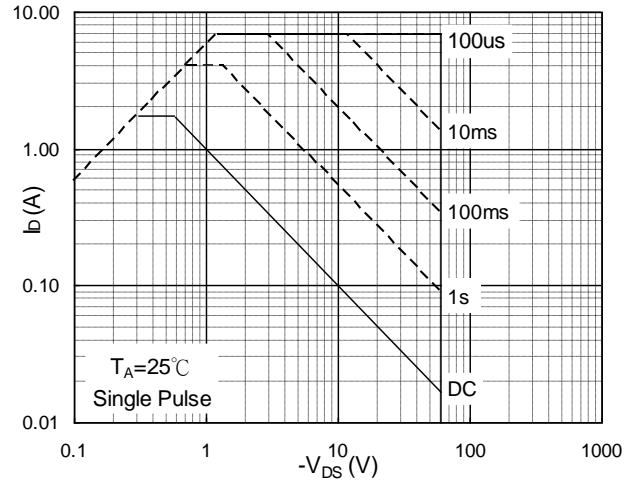


Fig.8 Safe Operating Area

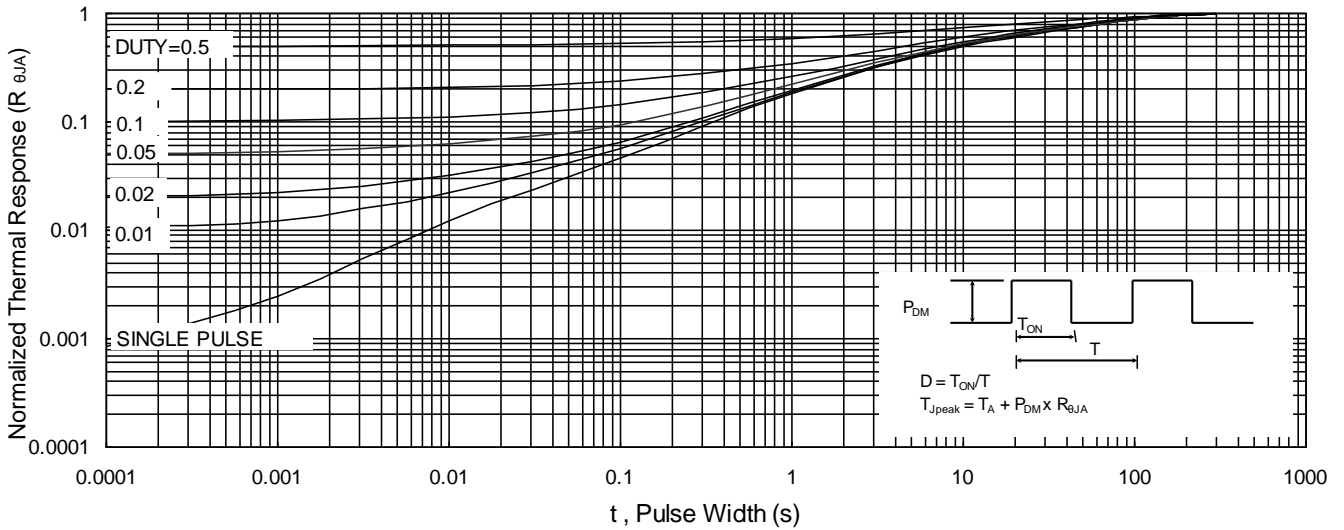


Fig.9 Normalized Maximum Transient Thermal Impedance

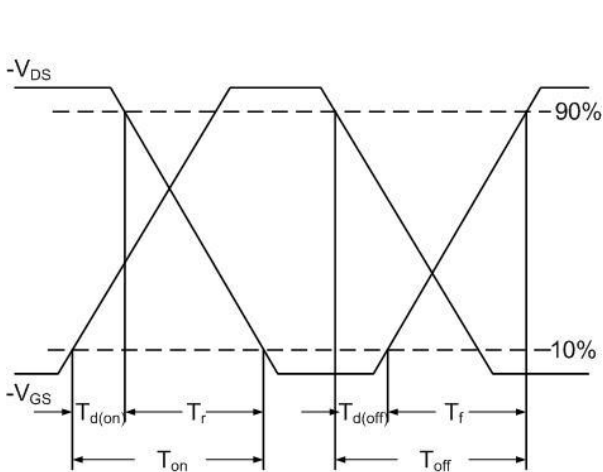


Fig.10 Switching time waveform

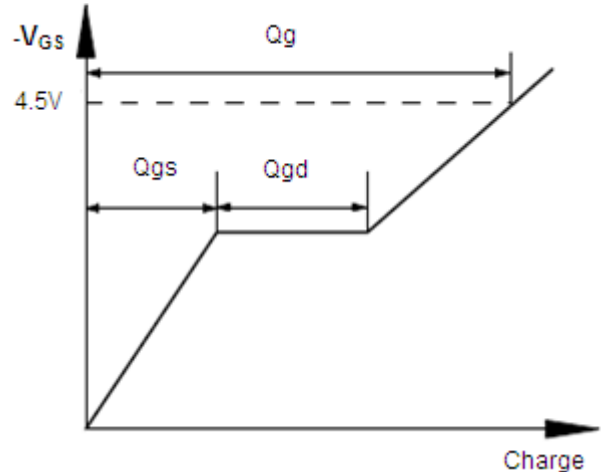


Fig.11 Gate Charge waveform